Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/676,208	WEN ET AL.	
Examiner	Art Unit	
Edna Wong	1753	

SEARCHED						
Class	Subclass	Date	Examiner			
205	123	2/22/2007	EW			
205	186	2/22/2007	EW			
205	210	2/22/2007	EW			
205	220	2/22/2007	EW			

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Search .	2/22/2007	EW		
EAST	2/22/2007	EW		
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